

Search Notes

Application/Control No.

10/630,019

Examiner

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Applicant(s)/Patent under
Reexamination

CHUEY, MARK D.

Art Unit

2635

SEARCHED

Class	Subclass	Date	Examiner
340	825.69	1/3/2006	NN
340	825.75	1/3/2006	NN
340	5.2	1/3/2006	NN
340	5.2+	1/3/2006	NN
340	5.7+	1/3/2006	NN
341	50	1/3/2006	NN
341	176	1/3/2006	NN
348	734	1/3/2006	NN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
SAME AS	ABOVE	1/3/2006	NN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search East: USPAT; US-PUBS; EPO; JPO and Derwent.	1/3/2006	NN